Unit in mm

TOSHIBA Diode Silicon Epitaxial Planar Type

HN2D01FU

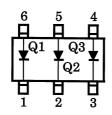
Ultra High Speed Switching Application

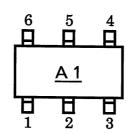
HN2D01FU is composed of 3 independent diodes.

Low forward voltage $: V_{F(3)} = 0.98V \text{ (typ.)}$ Fast reverse recovery time: $t_{rr} = 1.6$ ns (typ.) Small total capacitance $: C_T = 0.5pF \text{ (typ.)}$

Pin Assignment (Top View)

Marking





Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Maximum (peak) reverse Voltage	V_{RM}	85	V	
Reverse voltage	V _R	80	V	
Maximum (peak) forward current	I _{FM}	240 *	mA	
Average forward current	Io	80 *	mA	
Surge current (10ms)	I _{FSM}	1 *	Α	
Power dissipation	Р	200	mW	
Junction temperature	Tj	125	°C	
Storage temperature	T _{stg}	-55~125	°C	

2.1 ± 0.1 CATHODE **CATHODE CATHODE** 4. ANODE

1-2T1C

Weight: 6.2mg

5.

JEDEC

EIAJ **TOSHIBA**

ANODE 6. ANODE

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damage to property.

In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.

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[:] This is maximum rating of single diode (Q1 or Q2 or Q3). In the case of using 2 ro 3 diodes, the maximum ratings per diodes is 75 % of the single diode one.

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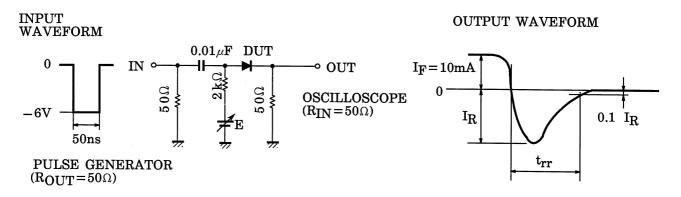
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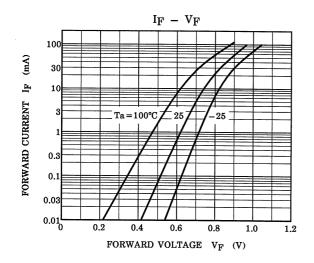
Electrical Characteristics (Q1 Q2 Q3 Common, Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Forward voltage	V _{F (1)}	_	I _F = 1mA	_	0.62	_	V
	V _{F (2)}	_	I _F = 10mA	-	0.75	1	
	V _{F (3)}	_	I _F = 100mA	_	0.98	1.20	
Reverse current	I _{R (1)}	_	V _R = 30V	_	_	0.1	μΑ
	I _{R (2)}	_	V _R = 80V	_	_	0.5	
Total capacitance	C _T	_	$V_R = 0$, $f = 1MH_Z$		0.5	3.0	pF
Reverse recovery time	t _{rr}	_	I _F = 10mA (Fig.1)		1.6	4.0	ns

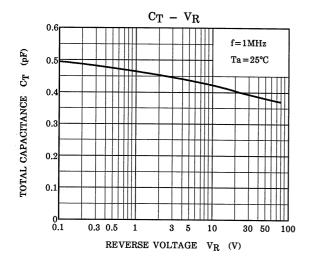
Fig.1 Reverse Recovery Time (t_{rr}) Test Circuit



Q1, Q2, Q3 Common



Q1, Q2, Q3 Common



Q1, Q2, Q3 Common

